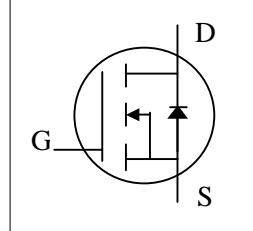


**XP9452GG-HF****Halogen-Free Product****N-CHANNEL ENHANCEMENT MODE
POWER MOSFET**

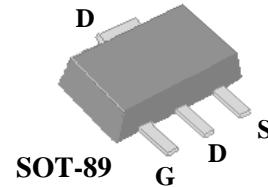
- ▼ Lower Gate Charge
- ▼ Capable of 2.5V Gate Drive
- ▼ Simple Drive Requirement
- ▼ RoHS Compliant



BV_{DSS}	20V
$R_{DS(ON)}$	50mΩ
I_D	4A

Description

XP9452 series are innovative design and silicon process technology to achieve the lowest possible on-resistance and fast switching performance. It provides the designer with an extreme efficient device for use in a wide range of power applications.



Absolute Maximum Ratings@ $T_j=25^\circ\text{C}$ (unless otherwise specified)

Symbol	Parameter	Rating	Units
V_{DS}	Drain-Source Voltage	20	V
V_{GS}	Gate-Source Voltage	± 16	V
$I_D @ T_A = 25^\circ\text{C}$	Drain Current, $V_{GS} @ 4.5\text{V}^3$	4	A
$I_D @ T_A = 70^\circ\text{C}$	Drain Current, $V_{GS} @ 4.5\text{V}^3$	2.5	A
I_{DM}	Pulsed Drain Current ¹	12	A
$P_D @ T_A = 25^\circ\text{C}$	Total Power Dissipation	1.25	W
	Linear Derating Factor	0.01	W/ $^\circ\text{C}$
T_{STG}	Storage Temperature Range	-55 to 150	$^\circ\text{C}$
T_J	Operating Junction Temperature Range	-55 to 150	$^\circ\text{C}$

Thermal Data

Symbol	Parameter	Value	Unit
R_{thj-a}	Maximum Thermal Resistance, Junction-ambient ³	100	$^\circ\text{C}/\text{W}$

Electrical Characteristics@ $T_j=25^\circ\text{C}$ (unless otherwise specified)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
BV_{DSS}	Drain-Source Breakdown Voltage	$\text{V}_{\text{GS}}=0\text{V}, \text{I}_D=250\mu\text{A}$	20	-	-	V
$\Delta \text{BV}_{\text{DSS}}/\Delta T_j$	Breakdown Voltage Temperature Coefficient	Reference to 25°C , $\text{I}_D=1\text{mA}$	-	0.03	-	$\text{V}/^\circ\text{C}$
$\text{R}_{\text{DS(ON)}}$	Static Drain-Source On-Resistance ²	$\text{V}_{\text{GS}}=10\text{V}, \text{I}_D=4\text{A}$	-	-	38	$\text{m}\Omega$
		$\text{V}_{\text{GS}}=4.5\text{V}, \text{I}_D=4\text{A}$	-	-	50	$\text{m}\Omega$
		$\text{V}_{\text{GS}}=2.5\text{V}, \text{I}_D=3\text{A}$	-	-	80	$\text{m}\Omega$
$\text{V}_{\text{GS(th)}}$	Gate Threshold Voltage	$\text{V}_{\text{DS}}=\text{V}_{\text{GS}}, \text{I}_D=250\mu\text{A}$	0.5	-	1.5	V
g_f	Forward Transconductance ²	$\text{V}_{\text{DS}}=5\text{V}, \text{I}_D=3\text{A}$	-	10	-	S
I_{DSS}	Drain-Source Leakage Current	$\text{V}_{\text{DS}}=20\text{V}, \text{V}_{\text{GS}}=0\text{V}$	-	-	1	uA
	Drain-Source Leakage Current ($T_j=70^\circ\text{C}$)	$\text{V}_{\text{DS}}=16\text{V}, \text{V}_{\text{GS}}=0\text{V}$	-	-	25	uA
I_{GSS}	Gate-Source Leakage	$\text{V}_{\text{GS}}= \pm 16\text{V}, \text{V}_{\text{DS}}=0\text{V}$	-	-	± 100	nA
Q_g	Total Gate Charge ²	$\text{I}_D=4\text{A}$	-	6	10	nC
Q_{gs}	Gate-Source Charge	$\text{V}_{\text{DS}}=16\text{V}$	-	1	-	nC
Q_{gd}	Gate-Drain ("Miller") Charge	$\text{V}_{\text{GS}}=4.5\text{V}$	-	2	-	nC
$t_{\text{d(on)}}$	Turn-on Delay Time ²	$\text{V}_{\text{DS}}=10\text{V}$	-	8	-	ns
t_r	Rise Time	$\text{I}_D=1\text{A}$	-	9	-	ns
$t_{\text{d(off)}}$	Turn-off Delay Time	$\text{R}_G=3.3\Omega$	-	13	-	ns
t_f	Fall Time	$\text{V}_{\text{GS}}=5\text{V}$	-	3	-	ns
C_{iss}	Input Capacitance	$\text{V}_{\text{GS}}=0\text{V}$	-	360	570	pF
C_{oss}	Output Capacitance	$\text{V}_{\text{DS}}=20\text{V}$	-	80	-	pF
C_{rss}	Reverse Transfer Capacitance	f=1.0MHz	-	65	-	pF

Source-Drain Diode

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
V_{SD}	Forward On Voltage ²	$\text{I}_S=1\text{A}, \text{V}_{\text{GS}}=0\text{V}$	-	-	1.3	V
t_{rr}	Reverse Recovery Time ²	$\text{I}_S=4\text{A}, \text{V}_{\text{GS}}=0\text{V},$ $d\text{I}/dt=100\text{A}/\mu\text{s}$	-	18	-	ns
Q_{rr}	Reverse Recovery Charge		-	10	-	nC

Notes:

- 1.Pulse width limited by Max. junction temperature.
- 2.Pulse test
- 3.Surface mount on FR4 board, t \leq 10s.

THIS PRODUCT IS SENSITIVE TO ELECTROSTATIC DISCHARGE, PLEASE HANDLE WITH CAUTION.

USE OF THIS PRODUCT AS A CRITICAL COMPONENT IN LIFE SUPPORT OR OTHER SIMILAR SYSTEMS IS NOT AUTHORIZED.

XSEMI DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT

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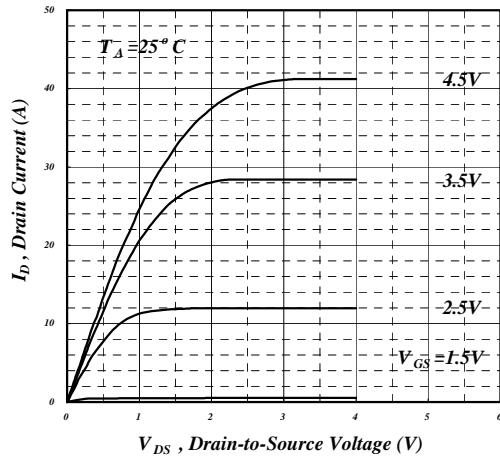


Fig 1. Typical Output Characteristics

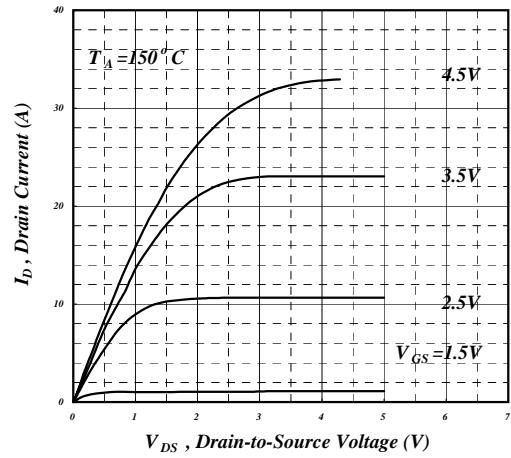


Fig 2. Typical Output Characteristics

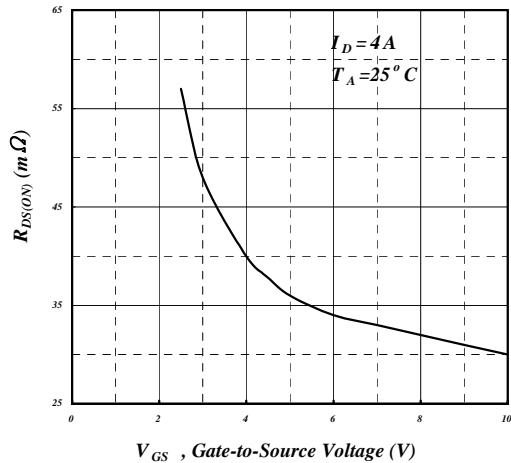


Fig 3. On-Resistance v.s. Gate Voltage

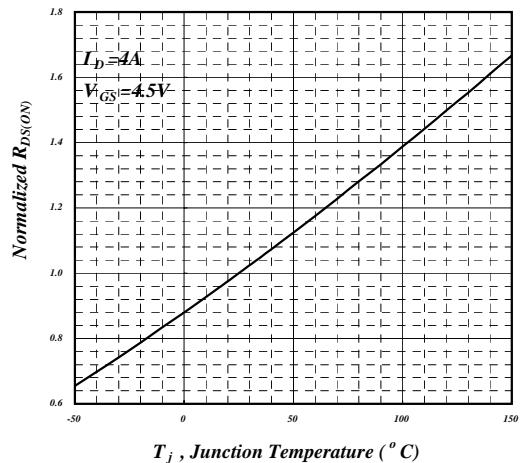


Fig 4. Normalized On-Resistance v.s. Junction Temperature

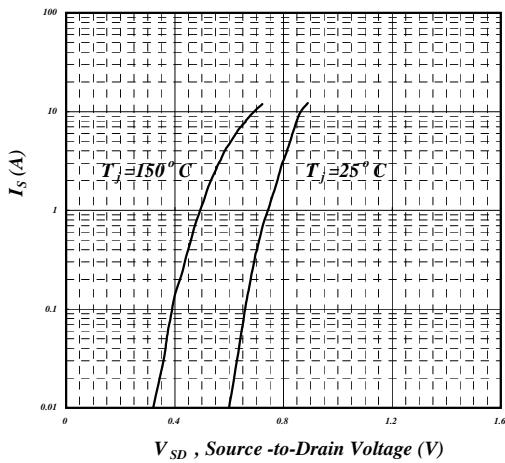


Fig 5. Forward Characteristic of Reverse Diode

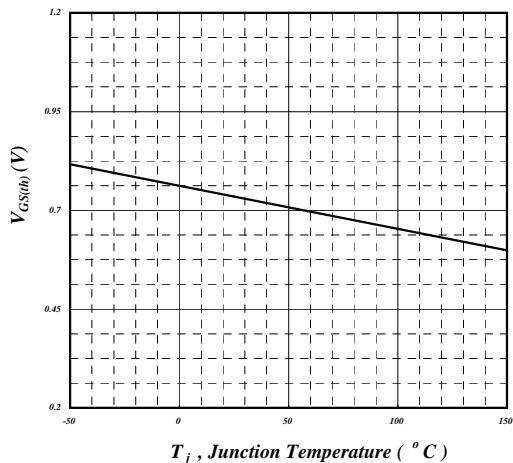
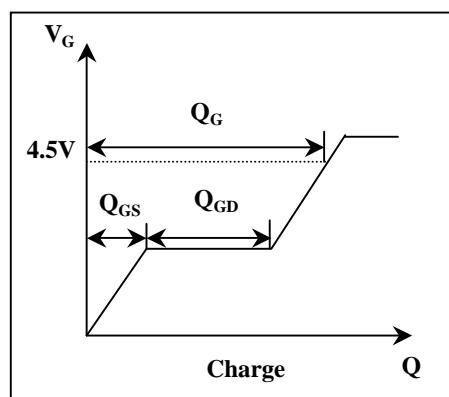
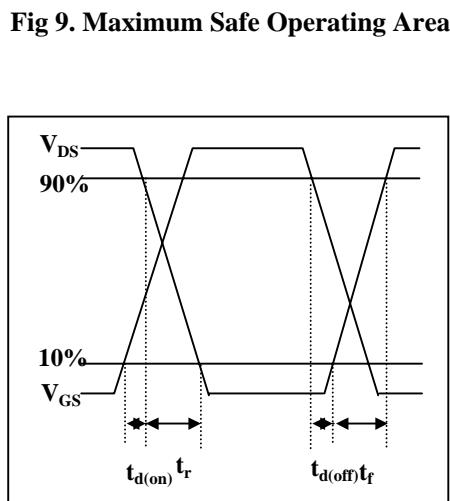
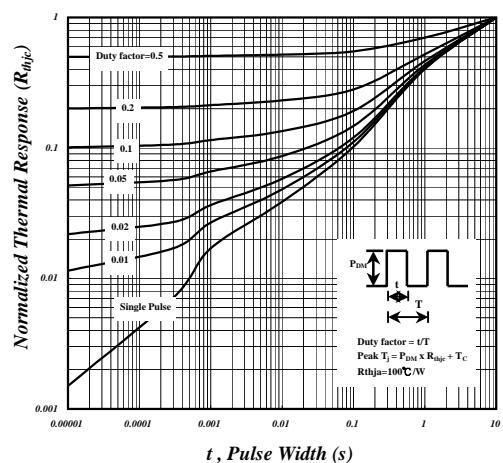
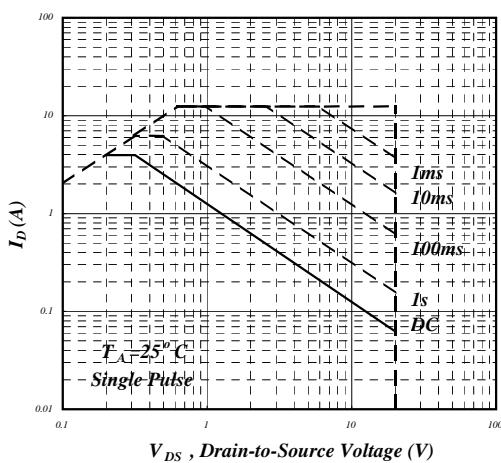
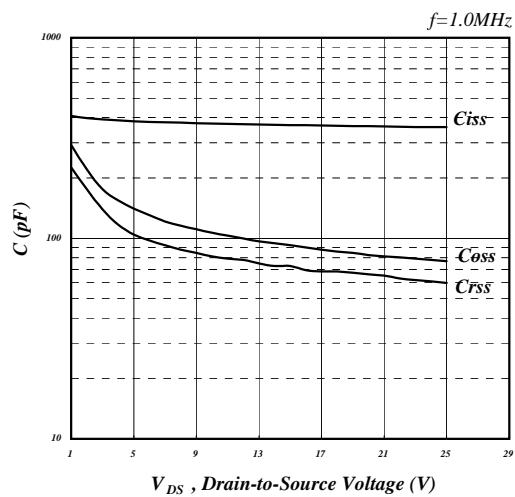
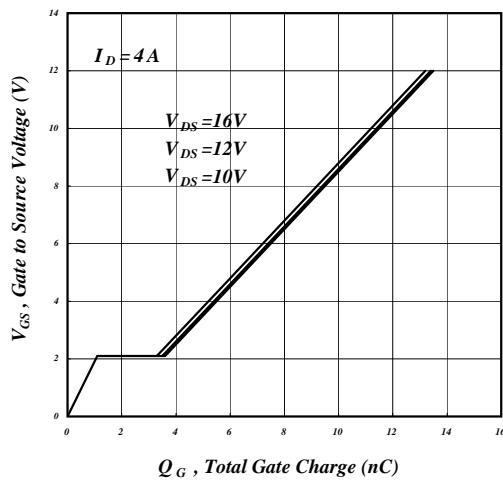


Fig 6. Gate Threshold Voltage v.s. Junction Temperature



MARKING INFORMATION